## Notice of References Cited Application/Control No. 10/762,521 Examiner Lee Lum Applicant(s)/Patent Under Reexamination BERTHIAUME, YVES Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,591,934	07-2003	Tsutsumikoshi, Shinobu	180/291
	В	US-6,626,260	09-2003	Gagnon et al.	180/291
	С	US-6,725,962	04-2004	Fukuda, Kazutaka	180/292
	D	US-5,052,990	10-1991	Sakakibara et al.	475/210
	Е	US-6,719,084	04-2004	Kuji et al.	180/309
	F	US-6,581,716	06-2003	Matsuura, Tatsuya	180/379
	G	US-6,666,290	12-2003	Yamauchi, Kosaku	180/68.1
	Н	US-6,547,024	04-2003	Ohyama et al.	180/227
	ı	US-6,454,031	09-2002	Szymkowiak, Zbigniew	180/6.2
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					-
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.